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August 2014

FDFS6N548

Integrated N-Channel PowerTrench® MOSFET and Schottky Diode 30V, 7A, 23m Ω

Features

- Max $r_{DS(on)}$ = 23m Ω at V_{GS} = 10V, I_D = 7A
- Max $r_{DS(on)}$ = 30m Ω at V_{GS} = 4.5V, I_D = 6A
- V_F < 0.45V @ 2A

V_F < 0.28V @ 100mA

- Schottky and MOSFET incorporated into single power surface mount SO-8 package
- Electrically independent Schottky and MOSFET pinout for design flexibility
- Low Miller Charge



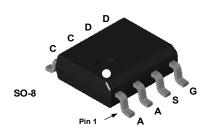
General Description

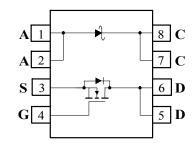
The FDFS6N548 combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in an SO-8 package.

This device is designed specifically as a single package solution for DC to DC converters. It features a fast switching, low gate charge MOSFET with very low on-state resistance. The independently connected Schottky diode allows its use in a variety of DC/DC converter topologies.

Application

■ DC/DC Conversion





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DS}	Drain to Source Voltage		30	V
V_{GS}	Gate to Source Voltage		±20	V
	Drain Current -Continuous (Note 1a)		7	۸
ID	-Pulsed		30	— A
D	Power Dissipation for Dual Operation		2	w
P_{D}	Power Dissipation for Single Operation	(Note 1a)	1.6	VV
E _{AS}	Drain-Source Avalanche Energy	(Note 3)	12	mJ
V_{RRM}	Schottky Repetitive Peak Reverse Voltage		30	V
I _O	Schottky Average Forward Current	(Note 1a)	2	Α
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	40	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDFS6N548	FDFS6N548	SO-8	330mm	12mm	2500 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24V,$ $V_{GS} = 0V$ $T_{J} = 125^{\circ}C$			1 250	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20V, V _{DS} = 0V			±100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.2	1.8	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C		-5		mV/°C
		V _{GS} = 10V, I _D = 7A		19	23	
r _{DS(on)}	Drain to Source On-Resistance	$V_{GS} = 4.5V, I_D = 6A$		23	30	mΩ
		V_{GS} = 10V, I_D = 7A, T_J = 125°C		26	31	
9 _{FS}	Forward Transconductance	$V_{DS} = 5V, I_{D} = 7A$		20		S

Dynamic Characteristics

C _{iss}	Input Capacitance	\\ -45\\\\ -0\\	525	700	pF
C _{oss}	Output Capacitance	V _{DS} = 15V, V _{GS} = 0V, f = 1MHz	100	133	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	65	100	pF
R_g	Gate Resistance	f = 1MHz	0.8		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	., ,_,,	6	12	ns
t _r	Rise Time	V_{DD} = 15V, I_{D} = 7A, V_{GS} = 10V, R_{GEN} = 6 Ω	2	10	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} - 10V, K _{GEN} - 052	14	25	ns
t _f	Fall Time		2	10	ns
$Q_{g(TOT)}$	Total Gate Charge at 10V	V _{DS} = 15V, I _D = 7A	9	13	nC
Q _{gs}	Gate to Source Gate Charge	V _{GS} = 10V	1.5		nC
Q_{gd}	Gate to Drain "Miller" Charge		2		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 7A$	(Note2)	0.90	1.25	V
t _{rr}	Reverse Recovery Time	I _E = 7A. di/dt = 100A/μs		23	35	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 7A$, $dI/dt = 100A/\mu s$		14	21	nC

Schottky Diode Characteristics

V_R	Reverse Breakdown Voltage	$I_R = -1mA$		-30			V
I _R Reverse Leakage	Deverage Leakers	\/ - 10\/	$T_J = 25^{\circ}C$		-39	-250	μА
	V _R = -10V	$T_J = 125^{\circ}C$		-18		mA	
V _F		I _E = 100mA	$T_J = 25^{\circ}C$		225	280	
	Forward Voltage	IF - TOOTIA	$T_J = 125^{\circ}C$		140		mV
	Forward voltage	I _F = 2A	T _J = 25°C		364	450	IIIV
			T _J = 125°C		290		

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Notes:

 $R_{\theta IA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta IC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



ωψψω b) 125°C/W when mounted on a 0.02 in² pad of 2 oz copper



c) 135°C/W when mounted on a minimun pad

- 2: Pulse Test: Pulse Width < $300\mu\text{s}$, Duty cycle < 2.0%.
- 3: Starting $T_J = 25$ °C, L = 1mH, $I_{AS} = 5.0$ A, $V_{DD} = 27$ V, $V_{GS} = 10$ V.

Typical Characteristics T_J = 25°C unless otherwise noted

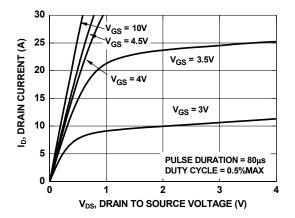


Figure 1. On Region Characteristics

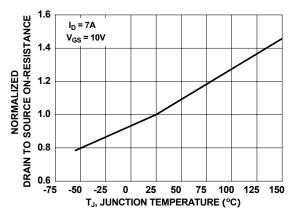


Figure 3. Normalized On-Resistance vs Junction Temperature

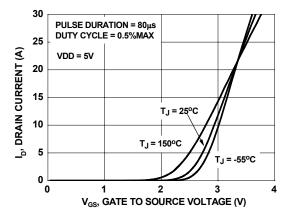


Figure 5. Transfer Characteristics

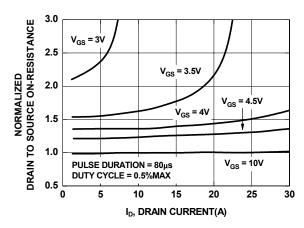


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

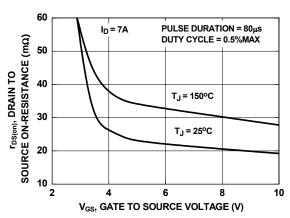


Figure 4. On-Resistance vs Gate to Source Voltage

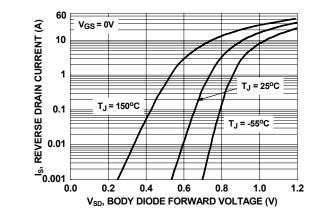


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

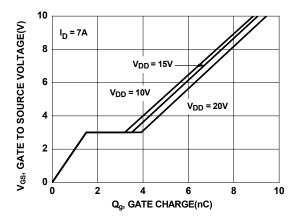


Figure 7. Gate Charge Characteristics

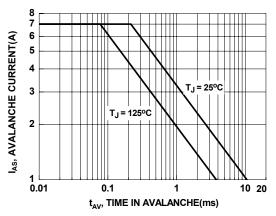


Figure 9. Unclamped Inductive Switching Capability

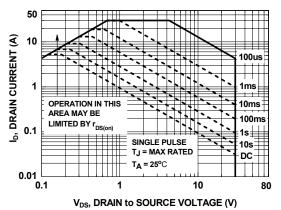


Figure 11. Forward Bias Safe Operating Area

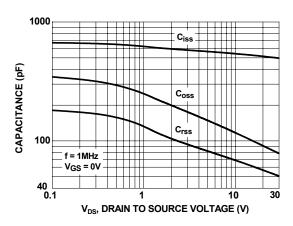


Figure 8. Capacitance vs Drain to Source Voltage

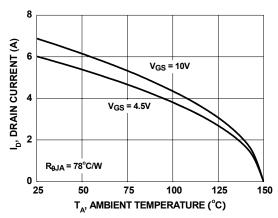


Figure 10. Maximum Continuous Drain Current vs Ambient Temperature

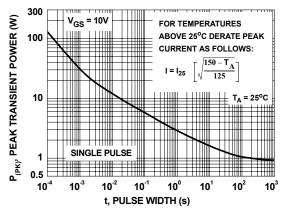
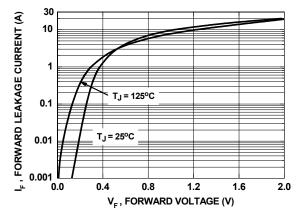


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted



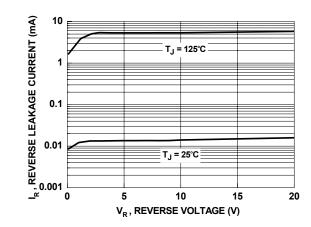


Figure 13. Schottky Diode Forward Characteristics

Figure 14. Schottky Diode Reverse Characteristics

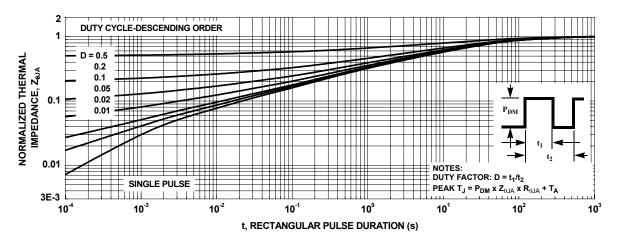
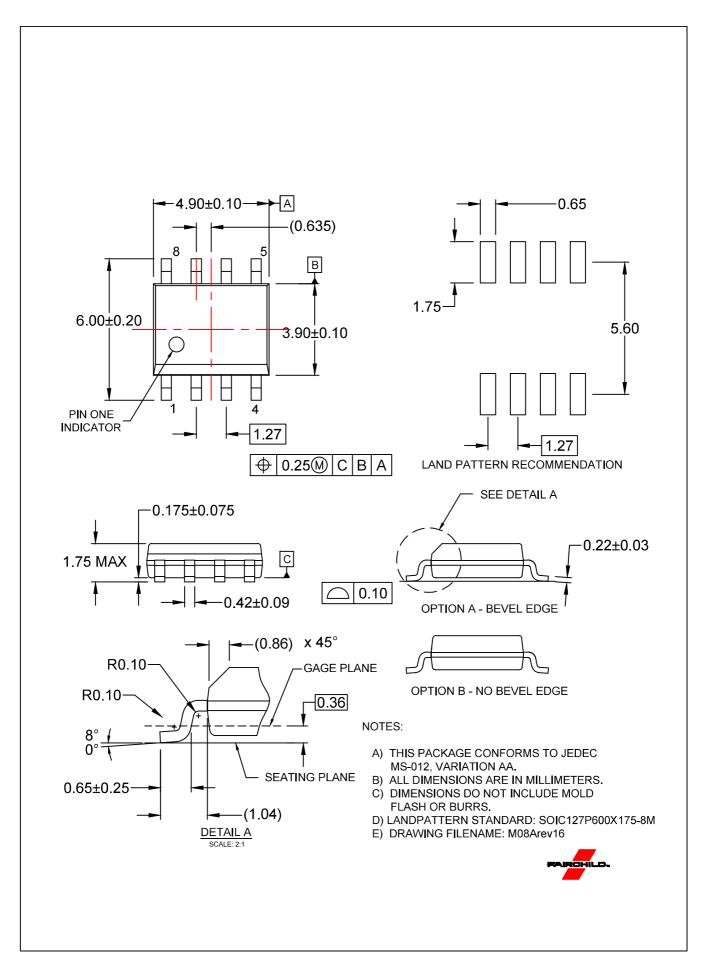


Figure 15. Transient Thermal Response Curve



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